

<b>Notice of References Cited</b>	Application/Control No. 10/549,353	Applicant(s)/Patent Under Reexamination JANG, HYEON-YONG	
	Examiner Ephrem Alemu	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,166,491	12-2000	Tsuchiya et al.	315/169.3
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